



Wide Band Matched Dual N-Channel JFETs

FEATURES

- High Gain Through 100Mhz $g_{fs} > 5000\text{mmho}$
- Low Offset 10mV Max
- Low Noise NF=1dB Max
- Matching Characteristics Specified
- Direct Pin Compatible Replacement To 2N5911/2N5912

APPLICATIONS

- Wideband Differential Amplifiers
- Precision Current Sources
- Source Follower
- Analog Switches

PRODUCT DESCRIPTION

The ALPHA Semiconductor 2N5911/2N5912 is a monolithic matched dual N-channel JFET. Matching characteristics include offset voltage pf 10mV max. and temperature drift of 20mV/ $^{\circ}\text{C}$. The high gain and high speed makes the 2N5911/2N5912 ideal for use in input high speed amplifiers.

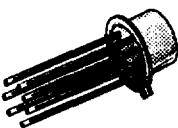
The 2N5911/2N5912 is available in a TO-78 package with an operating temperature range of -55 $^{\circ}\text{C}$ to +125 $^{\circ}\text{C}$ and Die form.

ORDERING INFORMATION

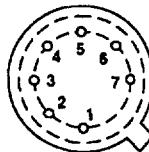
Part Number	Temp. Range	Package Type
2N5911H	-55 to +125 $^{\circ}\text{C}$	TO-78
2N5912H	-55 to +125 $^{\circ}\text{C}$	TO-78
2N5911X		Die Form
2N5912X		Die Form

PIN CONNECTIONS

TO-78



BOTTOM VIEW



- 1 SOURCE 1
- 2 DRAIN 1
- 3 GATE 1
- 4 CASE
- 5 SOURCE 2
- 6 DRAIN 2
- 7 GATE 2

ABSOLUTE MAXIMUM RATINGS

Gate-to-Gate Voltage	$\pm 80V$
Gate-Drain or Gate-Source Voltage	-25V
Gate Current	50mA
Device Dissipation(Each Side),(Derate 3mW/ $^{\circ}C$)	367mW

Total Device Dissipation.(Derate 4mW/ $^{\circ}C$)	500mW
Storage Temperature Range	-65 $^{\circ}C$ to +200 $^{\circ}C$
Lead Temperature(1/16 " from case for 10 Seconds)	300 $^{\circ}C$

ELECTRICAL CHARACTERISTICS at $T_a=25^{\circ}C$, unless otherwise specified.

Parameters	Symbols	Test Conditions	2N5911/2N5912		Units
STATIC					
Gate Reverse Current	I_{GSS}	$V_{in}=-15, V_{DS}=0$			-100 pA
Gate Reverse Current	I_{GS}	$V_{GS}=-15, V_{DS}=0$	$T_a=150^{\circ}C$		-250 nA
Gate-Source Breakdown Voltage	VG_{GSS}	$IG=-1mA, V_{DS}=0$		-25	V
Gate-Source Cutoff Voltage	$V_{GS(off)}$	$V_{DS}=10V, ID=1nA$		-1	-5
Gate-Source Voltage	V_{GS}	$V_{DG}=10V, ID=5mA$		-0.3	-4
Gate Operating Current	I_g	$V_{DG}=10V, ID=5mA$			-100 pA
Gate Operating Current	I_g	$V_{DG}=10V, ID=5mA$	$T_a=125^{\circ}C$		-100 nA
Saturation Drain Current (Note 1)	$Idss$	$V_{DS}=10V, V_{GS}=0$		7	40 mA
DYNAMIC					
Common-Source Forward Transconductance	g	$V_{DG}=10V, ID=5mA$	$f=1kHz$	5000	10.000 mmho
Common-Source Forward Transconductance	g	$V_{DG}=10V, ID=5mA$	$f=100MHz$	5000	10.000 mmho
Common-Source Output Conductance	g_{os}	$V_{DG}=10V, ID=5mA$	$f=1kHz$		100 mmho
Common-Source Output Conductance	g_{os}	$V_{DG}=10V, ID=5mA$	$f=100MHz$		150 mmho
Common-Source Output Capacitance	C	$V_{DG}=10V, ID=5mA$	$f=1MHz$		5 pF
Common-Source Reverse Transfer Capacitance	C	$V_{DG}=10V, ID=5mA$	$f=1MHz$		1.2 pF
Equivalent Short Circuit Input Noise Voltage	e_n	$V_{DG}=10V, ID=5mA$	$f=10kHz$		20 nV/Hz
Spot Noise Figure	NF	$V_{DG}=10V, ID=5mA$	$f=10kHz$ $R_o=100K$	1	dB

MATCHING ELECTRICAL CHARACTERISTICS at $T_a=25^{\circ}C$, unless otherwise specified.

Parameter	Symbols	Test Conditions	2N5911		2N5912		Units
			MIN	MAX	MIN	MAX	
Differential Gate Current	$IG1-IG2$	$V_{DG}=10V, ID=5mA$	$T_a=125^{\circ}C$		20	20	nA
Saturation Drain Current Ratio (Note 1, 2)	$IDSS1/IDSS2$	$V_{DS}=10V, V_{GS}=0$		0.95	1	0.95	1
Differential Gate-Source Voltage	$VGS1--VGS2$	$V_{DG}=10V, ID=5mA$			10		15 mA
Gate-Source Voltage Differential Drift (Note 3)	$DVGS1--VGS2$ DT	$V_{DG}=10V, ID=5mA$	$T_a=25^{\circ}C, T_a=125^{\circ}C,$ $T_a=25^{\circ}C, T_a=125^{\circ}C,$		20	40	mV/ $^{\circ}C$
Transconductance Ratio (Note 2)	$gfs1/gfs2$	$V_{DG}=10V, ID=5mA$	$f=1kHz$	0.95	1	0.95	1

Note 1: Pulsewidth £300ms, duty cycle £300ms

Note 2: Assuming smaller value in numerator

Note 3: Measures at end point T_A and T_B